

MC74AC157, MC74ACT157

Quad 2-Input Multiplexer

The MC74AC157/74ACT157 is a high-speed quad 2-input multiplexer. Four bits of data from two sources can be selected using the common Select and Enable inputs. The four outputs present the selected data in the true (noninverted) form.

The MC74AC157/74ACT157 can also be used as a function generator.

- Outputs Source/Sink 24 mA
- 'ACT157 Has TTL Compatible Inputs

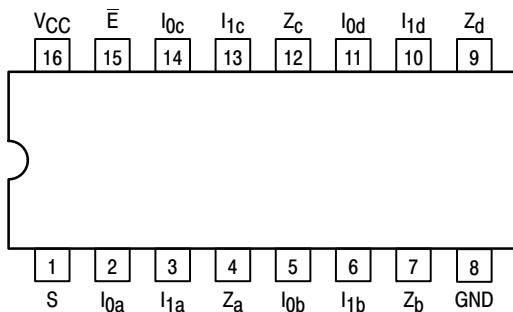


Figure 1. Pinout: 16-Lead Packages Conductors
(Top View)

PIN NAME

PIN	FUNCTION
I0a–I0d	Source 0 Data Inputs
I1a–I1d	Source 1 Data Inputs
E-bar	Enable Input
S	Select Input
Za–Zd	Outputs

TRUTH TABLE

Inputs			Outputs	
E	S	I0	I1	Z
H	X	X	X	L
L	H	X	L	L
L	H	X	H	H
L	L	L	X	L
L	L	H	X	H

H = HIGH Voltage Level

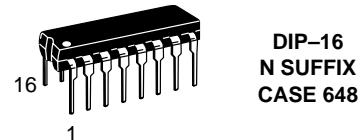
L = LOW Voltage Level

X = Immaterial



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DIP-16
N SUFFIX
CASE 648



SO-16
D SUFFIX
CASE 751B



TSSOP-16
DT SUFFIX
CASE 948F



EIAJ-16
M SUFFIX
CASE 966

ORDERING INFORMATION

Device	Package	Shipping
MC74AC157N	PDIP-16	25 Units/Rail
MC74ACT157N	PDIP-16	25 Units/Rail
MC74AC157D	SOIC-16	48 Units/Rail
MC74ACT157D	SOIC-16	48 Units/Rail
MC74AC157DR2	SOIC-16	2500 Tape & Reel
MC74ACT157DR2	SOIC-16	2500 Tape & Reel
MC74AC157DT	TSSOP-16	96 Units/Rail
MC74ACT157DT	TSSOP-16	96 Units/Rail
MC74AC157DTR2	TSSOP-16	2500 Tape & Reel
MC74ACT157DTR2	TSSOP-16	2500 Tape & Reel
MC74AC157M	EIAJ-16	50 Units/Rail
MC74ACT157M	EIAJ-16	50 Units/Rail
MC74AC157MEL	EIAJ-16	2000 Tape & Reel
MC74ACT157MEL	EIAJ-16	2000 Tape & Reel

DEVICE MARKING INFORMATION

See general marking information in the device marking section on page 152 of this data sheet.

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Figure 2. Logic Symbol

FUNCTIONAL DESCRIPTION

The MC74AC157/74ACT157 is a quad 2-input multiplexer. It selects four bits of data from two sources under the control of a common Select input (S). The Enable input (\bar{E}) is active-LOW. When \bar{E} is HIGH, all of the outputs (Z) are forced LOW regardless of all other inputs. The MC74AC157/74ACT157 is the logic implementation of a 4-pole, 2-position switch where the position of the switch is determined by the logic levels supplied to the Select input. The logic equations for the outputs are shown below:

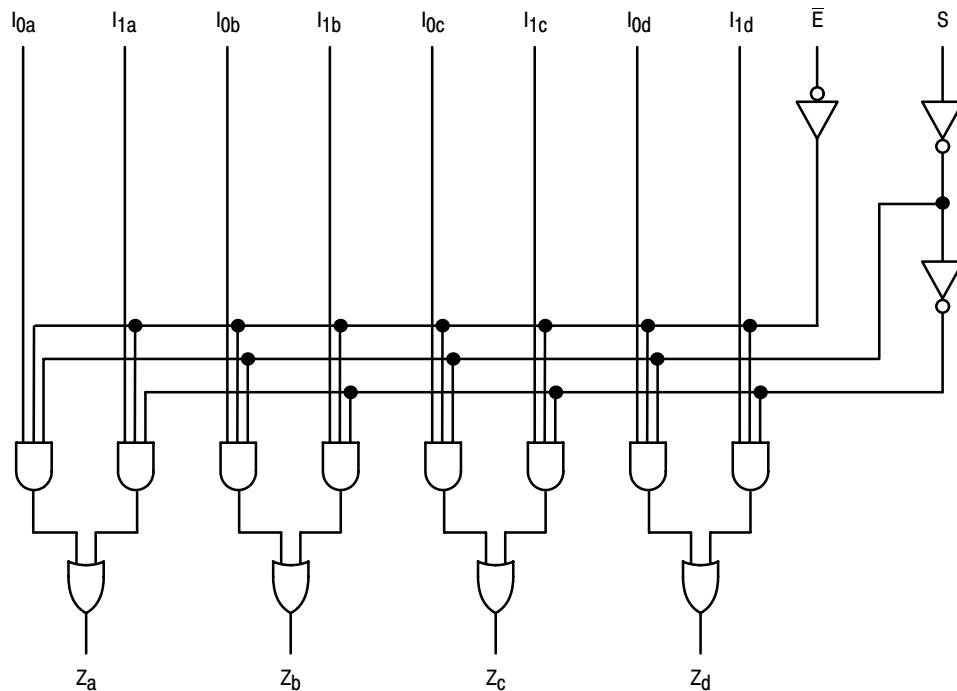
$$Z_a = \bar{E} \cdot (I_{1a} \cdot S + I_{0a} \cdot \bar{S})$$

$$Z_b = \bar{E} \cdot (I_{1b} \cdot S + I_{0b} \cdot \bar{S})$$

$$Z_C = \frac{\bar{E} \cdot (I_{1C} \cdot S + I_{0C} \cdot \bar{S})}{\bar{I}}$$

$$Z_d = \bar{E} \cdot (I_{1d} \cdot S + I_{0d} \cdot \bar{S})$$

A common use of the MC74AC157/74ACT157 is the moving of data from two groups of registers to four common output busses. The particular register from which the data comes is determined by the state of the Select input. A less obvious use is as a function generator. The MC74AC157/74ACT157 can generate any four of the sixteen different functions of two variables with one variable common. This is useful for implementing gating functions.



NOTE: This diagram is provided only for the understanding of logic operations and should not be used to estimate propagation delays.

Figure 3. Logic Diagram

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MAXIMUM RATINGS*

Symbol	Parameter	Value	Unit
V _{CC}	DC Supply Voltage (Referenced to GND)	−0.5 to +7.0	V
V _{IN}	DC Input Voltage (Referenced to GND)	−0.5 to V _{CC} +0.5	V
V _{OUT}	DC Output Voltage (Referenced to GND)	−0.5 to V _{CC} +0.5	V
I _{IN}	DC Input Current, per Pin	±20	mA
I _{OUT}	DC Output Sink/Source Current, per Pin	±50	mA
I _{CC}	DC V _{CC} or GND Current per Output Pin	±50	mA
T _{stg}	Storage Temperature	−65 to +150	°C

*Maximum Ratings are those values beyond which damage to the device may occur. Functional operation should be restricted to the Recommended Operating Conditions.

RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Min	Typ	Max	Unit
V _{CC}	Supply Voltage	'AC	2.0	5.0	6.0
		'ACT	4.5	5.0	5.5
V _{IN} , V _{OUT}	DC Input Voltage, Output Voltage (Ref. to GND)	0	—	V _{CC}	V
t _r , t _f	Input Rise and Fall Time (Note 1) 'AC Devices except Schmitt Inputs	V _{CC} @ 3.0 V	—	150	—
		V _{CC} @ 4.5 V	—	40	—
		V _{CC} @ 5.5 V	—	25	—
t _r , t _f	Input Rise and Fall Time (Note 2) 'ACT Devices except Schmitt Inputs	V _{CC} @ 4.5 V	—	10	—
		V _{CC} @ 5.5 V	—	8.0	—
T _J	Junction Temperature (PDIP)	—	—	140	°C
T _A	Operating Ambient Temperature Range	−40	25	85	°C
I _{OH}	Output Current – High	—	—	−24	mA
I _{OL}	Output Current – Low	—	—	24	mA

1. V_{IN} from 30% to 70% V_{CC}; see individual Data Sheets for devices that differ from the typical input rise and fall times.

2. V_{IN} from 0.8 V to 2.0 V; see individual Data Sheets for devices that differ from the typical input rise and fall times.

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DC CHARACTERISTICS

Symbol	Parameter	V_{CC} (V)	74AC		$T_A = -40^\circ C$ to $+85^\circ C$	Unit	Conditions			
			$T_A = +25^\circ C$							
			Typ	Guaranteed Limits						
V_{IH}	Minimum High Level Input Voltage	3.0 4.5 5.5	1.5 2.25 2.75	2.1 3.15 3.85	2.1 3.15 3.85	V	$V_{OUT} = 0.1 V$ or $V_{CC} - 0.1 V$			
V_{IL}	Maximum Low Level Input Voltage	3.0 4.5 5.5	1.5 2.25 2.75	0.9 1.35 1.65	0.9 1.35 1.65	V	$V_{OUT} = 0.1 V$ or $V_{CC} - 0.1 V$			
V_{OH}	Minimum High Level Output Voltage	3.0 4.5 5.5	2.99 4.49 5.49	2.9 4.4 5.4	2.9 4.4 5.4	V	$I_{OUT} = -50 \mu A$			
		3.0 4.5 5.5	— — —	2.56 3.86 4.86	2.46 3.76 4.76	V	* $V_{IN} = V_{IL}$ or V_{IH} $-12 mA$ I_{OH} $-24 mA$ $-24 mA$			
V_{OL}	Maximum Low Level Output Voltage	3.0 4.5 5.5	0.002 0.001 0.001	0.1 0.1 0.1	0.1 0.1 0.1	V	$I_{OUT} = 50 \mu A$			
		3.0 4.5 5.5	— — —	0.36 0.36 0.36	0.44 0.44 0.44	V	* $V_{IN} = V_{IL}$ or V_{IH} $12 mA$ I_{OL} $24 mA$ $24 mA$			
I_{IN}	Maximum Input Leakage Current	5.5	—	± 0.1	± 1.0	μA	$V_I = V_{CC}, GND$			
I_{OLD}	†Minimum Dynamic Output Current	5.5	—	—	75	mA	$V_{OLD} = 1.65 V$ Max			
I_{OHD}		5.5	—	—	-75	mA	$V_{OHD} = 3.85 V$ Min			
I_{CC}	Maximum Quiescent Supply Current	5.5	—	8.0	80	μA	$V_{IN} = V_{CC}$ or GND			

*All outputs loaded; thresholds on input associated with output under test.

†Maximum test duration 2.0 ms, one output loaded at a time.

NOTE: I_{IN} and I_{CC} @ 3.0 V are guaranteed to be less than or equal to the respective limit @ 5.5 V V_{CC} .

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AC CHARACTERISTICS (For Figures and Waveforms – See Section 3 of the ON Semiconductor FACT Data Book, DL138/D)

Symbol	Parameter	V_{CC}^* (V)	74AC			74AC		Unit	Fig. No.		
			$T_A = +25^\circ C$ $C_L = 50 \text{ pF}$			$T_A = -40^\circ C$ $\text{to } +85^\circ C$ $C_L = 50 \text{ pF}$					
			Min	Typ	Max	Min	Max				
t_{PLH}	Propagation Delay S to Z_n	3.3 5.0	1.5 1.5	7.0 5.5	11.5 9.0	1.5 1.5	13.0 10.0	ns	3–6		
t_{PHL}	Propagation Delay S to Z_n	3.3 5.0	1.5 1.5	6.5 5.0	11.0 8.5	1.5 1.0	12.0 9.5	ns	3–6		
t_{PLH}	Propagation Delay \bar{E} to Z_n	3.3 5.0	1.5 1.5	7.0 5.5	11.5 9.0	1.5 1.5	13.0 10.0	ns	3–6		
t_{PHL}	Propagation Delay \bar{E}_n to Z_n	3.3 5.0	1.5 1.5	6.5 5.5	11.0 9.0	1.5 1.0	12 9.5	ns	3–6		
t_{PLH}	Propagation Delay I_n to Z_n	3.3 5.0	1.5 1.5	5.0 4.0	8.5 6.5	1.0 1.0	9.0 7.0	ns	3–5		
t_{PHL}	Propagation Delay I_n to Z_n	3.3 5.0	1.5 1.5	5.0 4.0	8.0 6.5	1.0 1.0	9.0 7.0	ns	3–5		

*Voltage Range 3.3 V is $3.3 \text{ V} \pm 0.3 \text{ V}$.

*Voltage Range 5.0 V is $5.0 \text{ V} \pm 0.5 \text{ V}$.

DC CHARACTERISTICS

Symbol	Parameter	V_{CC} (V)	74ACT		74ACT		Unit	Conditions		
			$T_A = +25^\circ C$		$T_A = -40^\circ C$ $\text{to } +85^\circ C$					
			Typ	Guaranteed Limits	Typ	Guaranteed Limits				
V_{IH}	Minimum High Level Input Voltage	4.5 5.5	1.5 1.5	2.0 2.0	2.0 2.0		V	$V_{OUT} = 0.1 \text{ V}$ or $V_{CC} - 0.1 \text{ V}$		
V_{IL}	Maximum Low Level Input Voltage	4.5 5.5	1.5 1.5	0.8 0.8	0.8 0.8		V	$V_{OUT} = 0.1 \text{ V}$ or $V_{CC} - 0.1 \text{ V}$		
V_{OH}	Minimum High Level Output Voltage	4.5 5.5	4.49 5.49	4.4 5.4	4.4 5.4		V	$I_{OUT} = -50 \mu A$		
		4.5 5.5	– –	3.86 4.86	3.76 4.76		V	$*V_{IN} = V_{IL} \text{ or } V_{IH}$ $I_{OH} = -24 \text{ mA}$		
V_{OL}	Maximum Low Level Output Voltage	4.5 5.5	0.001 0.001	0.1 0.1	0.1 0.1		V	$I_{OUT} = 50 \mu A$		
		4.5 5.5	– –	0.36 0.36	0.44 0.44		V	$*V_{IN} = V_{IL} \text{ or } V_{IH}$ $I_{OL} = 24 \text{ mA}$		
I_{IN}	Maximum Input Leakage Current	5.5	–	± 0.1	± 1.0		μA	$V_I = V_{CC}, GND$		
ΔI_{CCT}	Additional Max. I_{CC} /Input	5.5	0.6	–	1.5		mA	$V_I = V_{CC} - 2.1 \text{ V}$		
I_{OLD}	†Minimum Dynamic Output Current	5.5	–	–	75		mA	$V_{OLD} = 1.65 \text{ V Max}$		
		5.5	–	–	–75		mA	$V_{OHD} = 3.85 \text{ V Min}$		
I_{CC}	Maximum Quiescent Supply Current	5.5	–	8.0	80		μA	$V_{IN} = V_{CC} \text{ or } GND$		

*All outputs loaded; thresholds on input associated with output under test.

†Maximum test duration 2.0 ms, one output loaded at a time.

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AC CHARACTERISTICS (For Figures and Waveforms – See Section 3 of the ON Semiconductor FACT Data Book, DL138/D)

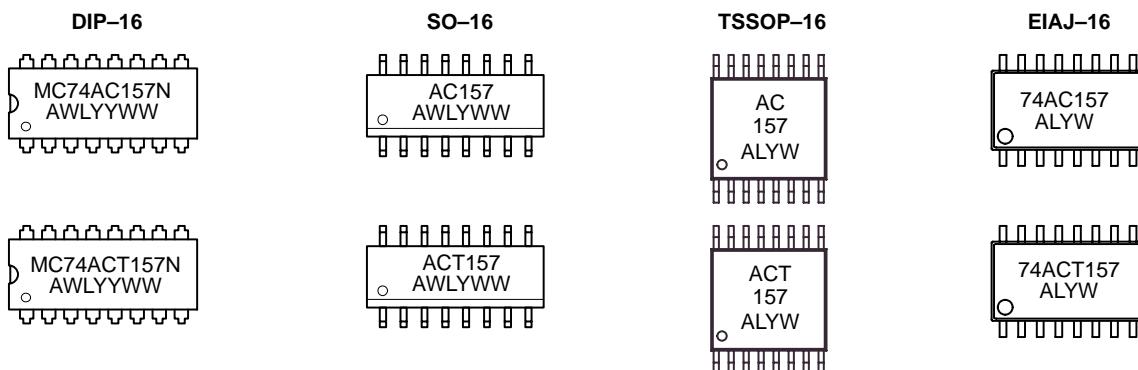
Symbol	Parameter	V _{CC} * (V)	74ACT			74ACT		Unit	Fig. No.		
			T _A = +25°C C _L = 50 pF			T _A = -40°C to +85°C C _L = 50 pF					
			Min	Typ	Max	Min	Max				
t _{PLH}	Propagation Delay S to Z _n	5.0	2.0	–	9.0	1.5	10.0	ns	3–6		
t _{PHL}	Propagation Delay S to Z _n	5.0	2.0	–	9.5	2.0	10.5	ns	3–6		
t _{PLH}	Propagation Delay E _n to Z _n	5.0	1.5	–	10	1.5	11.5	ns	3–6		
t _{PHL}	Propagation Delay E _n to Z _n	5.0	1.5	–	8.5	1.0	9.0	ns	3–6		
t _{PLH}	Propagation Delay I _n to Z _n	5.0	1.5	–	7.0	1.0	8.5	ns	3–5		
t _{PHL}	Propagation Delay I _n to Z _n	5.0	1.5	–	7.5	1.0	8.5	ns	3–5		

*Voltage Range 5.0 V is 5.0 V ±0.5 V.

CAPACITANCE

Symbol	Parameter	Value Typ	Unit	Test Conditions
C _{IN}	Input Capacitance	4.5	pF	V _{CC} = 5.0 V
C _{PD}	Power Dissipation Capacitance	50	pF	V _{CC} = 5.0 V

MARKING DIAGRAMS



A = Assembly Location
 WL, L = Wafer Lot
 YY, Y = Year
 WW, W = Work Week